Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/896,460	CUCIUREAN-ZAPAN ET AL.	
Examiner	Art Unit	
Jemme Grant II	2626	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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